Ignition IGBT Surface Mount > 400V > NGD18N40ACLB

NGD18N40ACLB - 18 A, 400 V, N-Channel Ignition IGBT, DPAK



ttelfuse

pertise Applied Answers Delivered

18 Amps, 400 Volts $VCE(on) \le 2.0 V @$ $IC = 10 A, VGE \ge 4.5 V$

Maximum Ratings (TJ = 25°C unless otherwise noted)

| Rating | Symbol | Value | Unit | | | |
|--|-----------------------------------|----------------|-----------------|--|--|--|
| Collector-Emitter Voltage | V _{CES} | 430 | V _{DC} | | | |
| Collector-Gate Voltage | V _{cer} | 430 | V _{DC} | | | |
| Gate-Emitter Voltage | V _{ge} | 18 | V _{DC} | | | |
| Collector Current–Continuous @TC = 25°C – Pulsed | I _c | 15 50 | A _{dc} | | | |
| ESD (Human Body Model) R = 1500 $\Omega,$ C = 100 pF | ESD | 8.0 | kV | | | |
| ESD (Machine Model) R = 0 Ω , C = 200 pF | ESD | 800 | V | | | |
| Total Power Dissipation @ TC = 25°C Derate above 25°C | PD | 115 0.77 | W W/°C | | | |
| Operating and Storage Temperature Range | T _J , T _{stg} | –55 to +175 | °C | | | |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Description

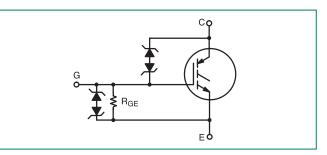
This Logic Level Insulated Gate Bipolar Transistor (IGBT) features monolithic circuitry integrating ESD and Over-Voltage clamped protection for use in inductive coil drivers applications. Primary uses include Ignition, Direct Fuel Injection, or wherever high voltage and high current switching is required.

Po

Features

- Ideal for Coil-on-Plug Applications
- DPAK Package Offers Smaller Footprint for Increased **Board Space**
- Gate-Emitter ESD Protection
- Temperature Compensated Gate-Collector Voltage Clamp Limits Stress Applied to Load
- Integrated ESD Diode Protection
- New Design Increases Unclamped Inductive Switching (UIS) Energy Per Area
- Low Threshold Voltage Interfaces Power Loads to Logic or **Microprocessor Devices**
- Low Saturation Voltage
- High Pulsed Current Capability
- Optional Gate Resistor (R_c) and Gate–Emitter Resistor (R_{GE})
- Emitter Ballasting for Short-Circuit Capability
- These are Pb-Free Devices

Functional Diagram



Additional Information







Samples



Unclamped Collector–To–Emitter Avalanche Characteristics (–55°≤T_J≤150°C)

| Rating | Symbol | Value | Unit | | | | |
|--|--------------------|-------|------|--|--|--|--|
| Single Pulse Collector-to-Emitter Avalanche Energy | | | | | | | |
| $V_{_{CC}}$ = 50 V, $V_{_{GE}}$ = 5.0 V, $P_{_{k}}$ I $_{_{L}}$ = 21.1 A, L = 1.8 mH, Starting $T_{_{\rm J}}$ = 25°C | | 400 | | | | | |
| $V_{_{CC}}$ = 50 V, $V_{_{GE}}$ = 5.0 V, $P_{_{K}}$ I $_{_{L}}$ = 16.2 A, L = 3.0 mH, Starting $T_{_{J}}$ = 25°C | E _{AS} | 400 | mJ | | | | |
| V_{cc} = 50 V, V_{gE} = 5.0 V, $P_k I_L$ = 18.3 A, L = 1.8 mH, Starting T_J = 125°C | | 300 | | | | | |
| Reverse Avalanche Energy | | | | | | | |
| V_{cc} = 100 V, V_{gE} = 20 V, $P_{k} I_{L}$ = 25.8 A, L = 6.0 mH, Starting T_{J} = 25°C | E _{AS(R)} | 2000 | mJ | | | | |

Maximum Short-Circuit Times $(-55^{\circ} \le T_{1} \le 150^{\circ}C)$

| Rating | Symbol | Value | Unit |
|---|------------------|-------|------|
| Short Circuit Withstand Time 1 (See Figure 17, 3 Pulses with 10 ms Period) | t _{sc1} | 750 | μs |
| Short Circuit Withstand Time 2 (See Figure 18, 3 Pulses with 10 ms Period) | t _{sc2} | 5.0 | ms |

| Thermal Characteristics | | | | | | | |
|---|------------------|-------|------|--|--|--|--|
| Rating | Symbol | Value | Unit | | | | |
| Thermal Resistance, Junction to Case | R _{ejc} | 1.3 | °C/W | | | | |
| Thermal Resistance, Junction to Ambient DPAK (Note 1) | R _{eja} | 95 | °C/W | | | | |
| Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds | TL | 275 | °C | | | | |



| Electrice | Char | acteristics | - 0 | |
|-----------|------|-------------|-----|---|
| Electrica | | acteristics | - 0 | 1 |
| | | | | |

| Characteristic | Symbol | Test Conditions | Temperature | Min | Тур | Max | Unit |
|--|----------------------|---|--|-----|-----|-----|------------------|
| | | l _c = 2.0 mA | $T_{J} = -40^{\circ}C$ to 150°C | 380 | 395 | 420 | |
| Collector–Emitter Clamp Voltage | BV _{CES} | I _c = 10 mA | $T_{J} = -40^{\circ}C$ to 150°C | 390 | 405 | 430 | V _{DC} |
| | | | T _J = 25°C | _ | 2.0 | 20 | |
| | | V _{ce} = 350 V, V _{ge} = 0 V | T _J = 150°C | _ | 10 | 40* | |
| Zero Gate Voltage Collector Current | I _{CES} | | T _J = −40°C | _ | 1.0 | 10 | μΑ _{DC} |
| | | V _{ce} = 15 V, V _{ge} = 0 V | T _J = 25°C | _ | _ | 2.0 | |
| | | | T _J = 25°C | - | 0.7 | 1.0 | |
| Reverse Collector-Emitter Leakage Current | I _{ECS} | $V_{ce} = -24 V$ | T _J = 150°C | - | 12 | 25* | mA |
| | | | $T_{J} = -40^{\circ}C$ | - | 0.1 | 1.0 | |
| | | | T_ = 25°C | 27 | 33 | 37 | |
| Reverse Collector–Emitter Clamp Voltage | B _{VCES(R)} | l _c = -75 mA | T _J = 150°C | 30 | 36 | 40 | $V_{\rm DC}$ |
| | | | $T_{J} = -40^{\circ}C$ | 25 | 32 | 35 | |
| Gate-Emitter Clamp Voltage | BV _{GES} | l _g = 5.0 mA | $T_J = -40^{\circ}C$ to $150^{\circ}C$ | 11 | 13 | 15 | V _{DC} |
| Gate-Emitter Leakage Current | I _{GES} | $V_{ge} = 10 V$ | $T_J = -40^{\circ}C$ to $150^{\circ}C$ | 384 | 640 | 700 | μΑ _{DC} |
| Gate Emitter Resistor | R _{ge} | _ | $T_{J} = -40^{\circ}C$ to 150°C | 10 | 16 | 26 | kΩ |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted.

Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. When surface mounted to an FR4 board using the minimum recommended pad size.

*Maximum Value of Characteristic across Temperature Range.



Electrical Characteristics - ON (Note 2)

| Characteristic | Symbol | Test Conditions | Temperature | Min | Тур | Max | Unit | | | | |
|---|---------------------|--|------------------------------------|------------------------|------|---|------------------------|-----|-----|------|---|
| | | 10 m | T _J = 25°C | 1.1 | 1.4 | 1.9 | | | | | |
| Gate Threshold Voltage | $V_{\text{GE(th)}}$ | $I_c = 1.0 \text{ mA},$ $V_{ge} = V_{ce}$ | T _J = 150°C | 0.75 | 1.0 | 1.4 | V _{DC} | | | | |
| | | V _{GE} = V _{CE} | $T_{J} = -40^{\circ}C$ | 1.2 | 1.6 | 2.1* | | | | | |
| Threshold Temperature Coefficient (Negative) | - | - | - | _ | 3.4 | _ | mV/ºC | | | | |
| | | | $T_{J} = 25^{\circ}C$ | 1.0 | 1.4 | 1.6 | | | | | |
| | | I _c = 6.0 A, V _{GE} = 4.0 V | T _J = 150°C | 0.9 | 1.3 | 1.6 | | | | | |
| | | V _{GE} = 4.0 V | T_= −40°C | 1.1 | 1.45 | 1.7* | | | | | |
| | | | $T_{J} = 25^{\circ}C$ | 1.3 | 1.6 | 1.9* |] | | | | |
| | | I _c = 8.0 A, | T _J = 150°C | 1.2 | 1.55 | 1.8 | | | | | |
| | V _{CE(on)} | l _c | $V_{ge} = 4.0 V$ | T_= −40°C | 1.4 | 1.6 | 1.9* | | | | |
| | | | | | | | T_ = 25°C | 1.4 | 1.8 | 2.05 | |
| | | | | | | I _c = 10 A, V _{GE} = 4.0 V | T _J = 150°C | 1.4 | 1.8 | 2.0 | 1 |
| Collector-to-Emitter On-Voltage | | V _{GE} = 4.0 V | T_= −40°C | 1.4 | 1.8 | 2.1* | V _{DC} | | | | |
| | CE(01) | L _ 15 A | T _J = 25°C | 1.8 | 2.2 | 2.5 | DC | | | | |
| | | I _c = 15 A, V _{GE} = 4.0 V | T _J = 150°C | 2.0 | 2.4 | 2.6* | | | | | |
| | | V _{GE} - 4.0 V | T_= -40°C | 1.7 | 2.1 | 2.5 |] | | | | |
| | | | T_ = 25°C | 1.3 | 1.8 | 2.0* | | | | | |
| | | $l_{c} = 10 \text{ A},$ | T _J = 150°C | 1.3 | 1.75 | 2.0* | | | | | |
| | | V _{GE} = 4.5 | V _{GE} = 4.5 V | T _J = −40°C | 1.4 | 1.8 | 2.0* | | | | |
| | | I _c = 6.5 A, V _{GE} = 3.7 V | T _J = 25°C | _ | _ | 1.65 | | | | | |
| Forward Transconductance | gfs | V _{CE} = 5.0 V, I _C = 6.0 A | T _J = −40°C to 150°C | 8.0 | 14 | 25 | Mhos | | | | |

Dynamic Characteristics

| Characteristic | Symbol | Test Conditions | Temperature | Min | Тур | Max | Unit |
|----------------------|------------------|------------------------------------|---------------------------------------|-----|-----|------|------|
| Input Capacitance | C _{ISS} | V - 25 V | | 400 | 800 | 1000 | |
| Output Capacitance | C _{oss} | $V_{CC} = 25 V,$ $V_{GE} = 0 V$ | T _J = −40°C to 150°C | 50 | 75 | 100 | pF |
| Transfer Capacitance | C _{RSS} | f = 1.0 MHz | | 4.0 | 7.0 | 10 | |



| Switiching Characteristics | | | | | | | |
|---------------------------------|---------------------|--|-----------------------|-----|-----|-----|------|
| Characteristic | Symbol | Test Conditions | Temperature | Min | Тур | Max | Unit |
| Turn–Off Delay Time (Resistive) | t _{d(off)} | $\begin{split} V_{cc} &= 300 \text{ V}, \\ I_{c} &= 6.5 \text{ A} \\ R_{g} &= 1.0 \text{ k}\Omega, \\ R_{L} &= 46 \Omega, \end{split}$ | T _J = 25°C | _ | 4.0 | 10 | 20 |
| Fall Time (Resistive) | tf | $\begin{split} V_{cc} &= 300 \text{ V}, \\ I_{c} &= 6.5 \text{ A} \\ R_{g} &= 1.0 \text{ k}\Omega, \\ R_{L} &= 46 \Omega, \end{split}$ | T _J = 25°C | _ | 9.0 | 15 | μS |
| Turn-On Delay Time | t _{d(on)} | $\begin{split} V_{cc} &= 10 \text{ V}, \\ I_{c} &= 6.5 \text{ A} \\ R_{g} &= 1.0 \text{ k}\Omega, \\ R_{L} &= 1.5 \Omega, \end{split}$ | T _J = 25°C | _ | 0.7 | 4.0 | |
| Rise Time | t _r | $\begin{split} V_{cc} &= 10 \text{ V}, \\ I_{c} &= 6.5 \text{ A} \\ R_{g} &= 1.0 \text{ k}\Omega, \\ R_{L} &= 1.5 \Omega, \end{split}$ | T _J = 25°C | _ | 4.5 | 7.0 | μS |

*Maximum Value of Characteristic across Temperature Range.

1. When surface mounted to an FR4 board using the minimum recommended pad size.

2. Pulse Test: Pulse Width \leq 300 $\mu S,$ Duty Cycle \leq 2%.

Ratings and Characteristic Curves

Figure 1. Output Characteristics

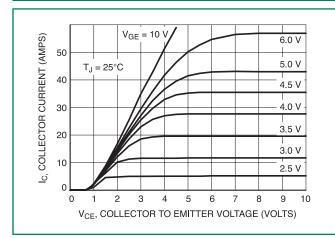


Figure 2. Output Characteristics

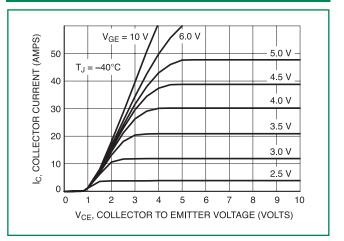




Figure 3. Output Characteristics

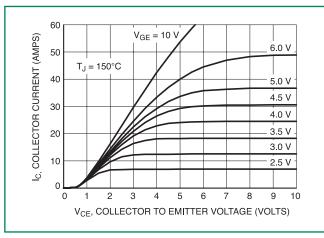
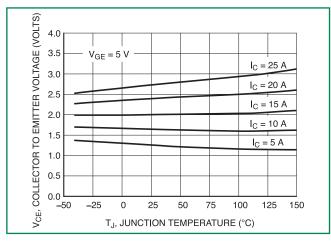


Figure 5. Collector-to-Emitter Saturation Voltage vs Junction Temperature



3 COLLECTOR TO EMITTER VOLTAGE (VOLTS) T_J = 150°C 2.5 I_C = 15 A 2 I_C = 10 A 1.5 $I_{\rm C} = 5 \, \text{A}$ 1 0.5 0 4 5 6 7 8 9 10 3 GATE TO EMITTER VOLTAGE (VOLTS)

Figure 7. Collector-to-Emitter Voltage vs

Gate-to-Emitter Voltage

Figure 4. Transfer Characteristics

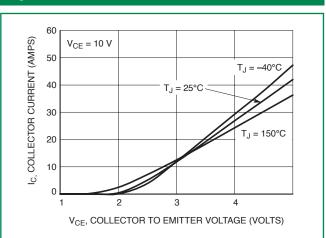


Figure 6. Collector-to-Emitter Voltage versus Gate-to-Emitter Voltage

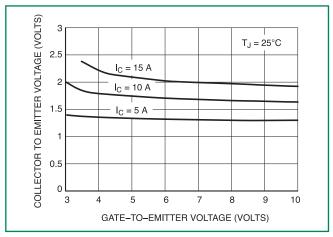
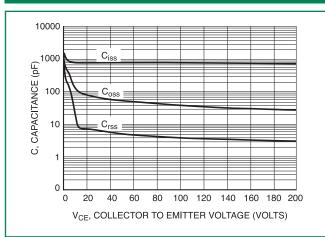


Figure 8. Capacitance Variation





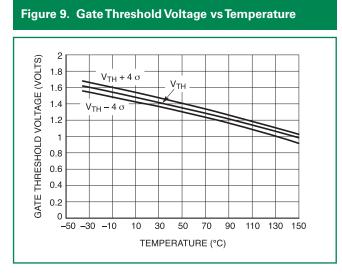


Figure 11. Typical Open Secondary Latch Current vs Temperature

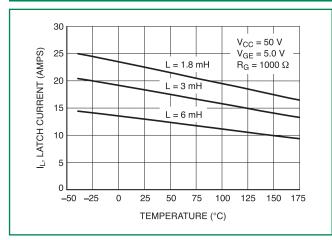


Figure 13. Single Pulse Safe Operating Area (Mounted on an Infinite Heatsink at $T_{r} = 25^{\circ}$ C)

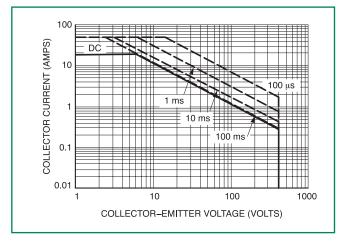


Figure 10. Minimum Open Secondary Latch Current vs Temperature

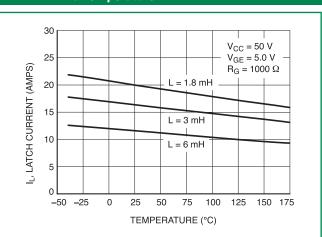


Figure 12. Inductive Switching Fall Time vs Temperature

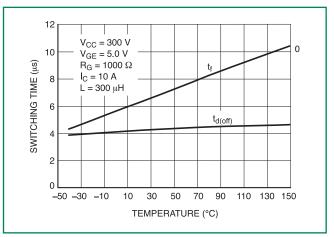


Figure 14. Single Pulse Safe Operating Area (Mounted on an Infinite Heatsink at $T_{A} = 125^{\circ}$ C)

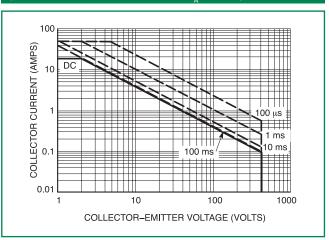




Figure 15. Pulse Train Safe Operating Area (Mounted on an Infinite Heatsink at $T_c = 25$ °C)

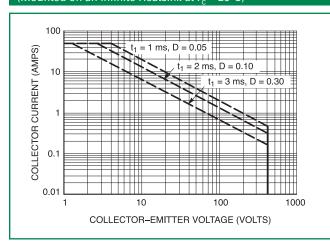


Figure 17. Circuit Configuration for Short Circuit Test #1

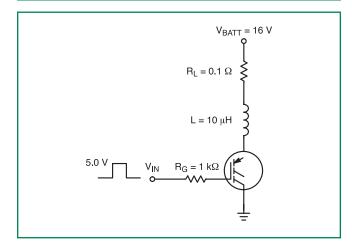


Figure 15. Pulse Train Safe Operating Area (Mounted on an Infinite Heatsink at $T_c = 125$ °C)

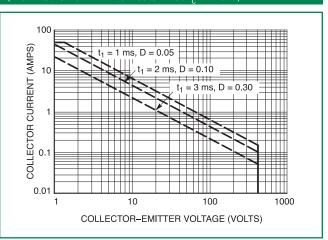
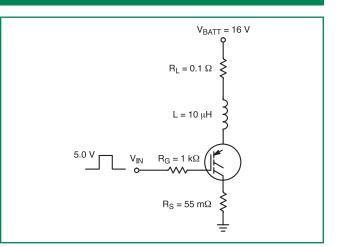
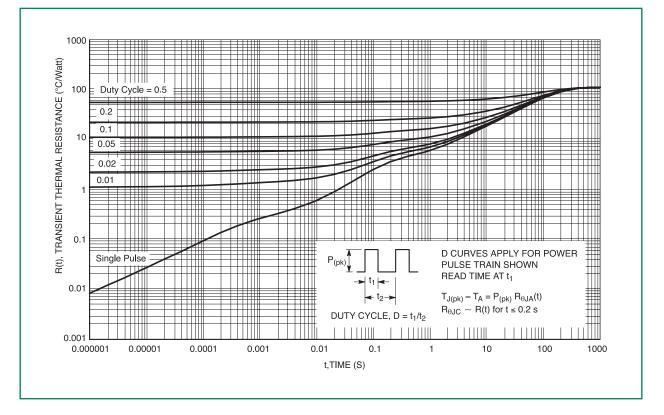


Figure 18. Circuit Configuration for Short Circuit Test #2





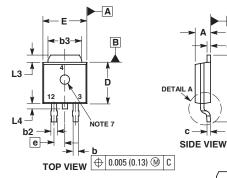


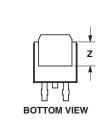




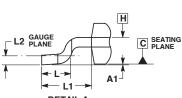
Ignition IGBT Surface Mount > 400V > NGD18N40ACLB

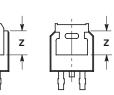
Dimensions





С





BOTTOM VIEW ALTERNATE CONSTRUCTIONS

DETAIL A ROTATED 90° CW

| | Inc | hes | Millin | neters |
|-----|-----------|-------|----------|--------|
| Dim | Min | Max | Min | Max |
| А | 0.086 | 0.094 | 2.18 | 2.38 |
| A1 | 0.000 | 0.005 | 0.00 | 0.13 |
| b | 0.025 | 0.035 | 0.63 | 0.89 |
| b2 | 0.028 | 0.045 | 0.72 | 1.14 |
| b3 | 0.180 | 0.215 | 4.57 | 5.46 |
| С | 0.018 | 0.024 | 0.46 | 0.61 |
| c2 | 0.018 | 0.024 | 0.46 | 0.61 |
| D | 0.235 | 0.245 | 5.97 | 6.22 |
| E | 0.250 | 0.265 | 6.35 | 6.73 |
| е | 0.090 | BSC | 2.29 BSC | |
| Н | 0.370 | 0.410 | 9.40 | 10.41 |
| L | 0.055 | 0.070 | 1.40 | 1.78 |
| L1 | 0.114 REF | | 2.90 | REF |
| L2 | 0.020 BSC | | 0.51 | BSC |
| L3 | 0.035 | 0.050 | 0.89 | 1.27 |
| L4 | | 0.040 | | 1.01 |
| Z | 0.155 | | 3.93 | |

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

2. CONTROLLING DIMENSION: INCHES.

3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.

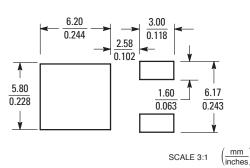
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

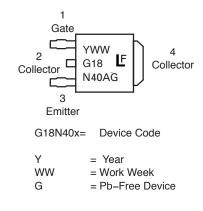
6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

7. OPTIONAL MOLD FEATURE.

Soldering Footrpint



Part Marking System



ORDERING INFORMATION

| Device | Package | Shipping† |
|-----------------|-------------------|-----------------------|
| NGB18N40ACLBT4G | DPAK (Pb-Free) | 2500 / Tape & Reel |

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